



<b>Search Notes</b>  	Application/Control No.  10822843	Applicant(s)/Patent Under Reexamination  HAYANO ET AL.
	Examiner Toth, Karen E	Art Unit 3735


Notes	Date	Examiner
Searched PALM (USPAT, USPGPUB)	6/28/06	ket
Class/subclass and keyword search	6/28/06	ket
PALM inventor name search	6/28/06	ket
See attached notes		
U.S. Patent and Trademark Office		Part of Paper No.: 051106

<b><i>Interference Searched</i></b>  	Application/Control No.  10822843	Applicant(s)/Patent Under Reexamination  HAYANO ET AL.
	Examiner  Toth, Karen E	Art Unit  3735

Class	SubClass	Date	Examiner
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See Notes

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	<p>Examiner</p> <p>Toth, Karen E</p>	<p>Art Unit</p> <p>3735</p>

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